TOSHIBA



TLCS-47 Series

TMP47P241VMG
TMP47P241VMG

TOSHIBA CORPORATION

Semiconductor Company

Document Change Notification

The purpose of this notification is to inform customers about the launch of the Pb free version of the device. The introduction of a Pb-free replacement affects the datasheet. Please understand that this notification is intended as a temporary substitute for a revision of the datasheet.

Changes to the datasheet may include the following, though not all of them may apply to this particular device.

1. Part number

Example: TMPxxxxxxFG TMPxxxxxxFG

All references to the previous part number were left unchanged in body text. The new part number is indicated on the prelims pages (cover page and this notification).

2. Package code and package dimensions

Example: LQFP100-P-1414-0.50C

LQFP100-P-1414-0.50F

All references to the previous package code and package dimensions were left unchanged in body text. The new ones are indicated on the prelims pages.

3. Addition of notes on lead solderability

Now that the device is Pb free, notes on lead solderability have been added.

Ι

4. RESTRICTIONS ON PRODUCT USE

The previous (obsolete) provision might be left unchanged on page 1 of body text. A new replacement is included on the next page.

5. Publication date of the datasheet

The publication date at the lower right corner of the prelims pages applies to the new device.

1. Part number

Package code and dimensions

Previous Part Number (in Body Text)	Previous Package Code (in Body Text)	New Part Number	New Package Code	ОТР
TMP47P241VN	P-SDIP28-400-1.78	TMP47P241VNG	SDIP28-P-400-1.78	_
TMP47P241VM	P-SOP28-450-1.27	TMP47P241VMG	SOP28-P-450-1.27B)	_

^{*:} For the dimensions of the new package, see the attached Package Dimensions diagram.

3. Addition of notes on lead solderability

The following solderability test is conducted on the new device.

Lead solderability of Pb-free devices (with the G suffix)

Test	Test Conditions	Remark
Solderability	(1) Use of Lead (Pb) -solder bath temperature = 230°C -dipping time = 5 seconds -the number of times = once -use of R-type flux (2) Use of Lead (Pb)-Free -solder bath temperature = 245°C -dipping time = 5 seconds -the number of times = once -use of R-type flux	Leads with over 95% solder coverage till lead forming are acceptable.

4. RESTRICTIONS ON PRODUCT USE

The following replaces the "RESTRICTIONS ON PRODUCT USE" on page 1 of body text.

RESTRICTIONS ON PRODUCT USE

20070701-EN

- The information contained herein is subject to change without notice.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.

In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.

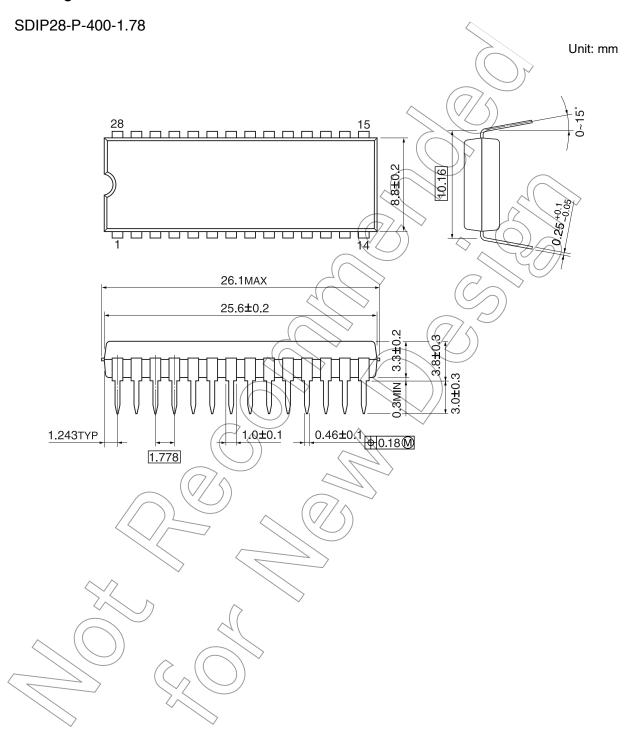
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in his document shall be made at the icustomer's own risk.
- The products described in this document shall not be used or embedded to any downstream products of which manufacture, use and/or sale are prohibited under any applicable laws and regulations.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility
 is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which may result from its
 use. No license is granted by implication or otherwise under any patents or other rights of TOSHIBA or the third
 parties.
- Please contact your sales representative for product-by-product details in this document regarding RoHS
 compatibility. Please use these products in this document in compliance with all applicable laws and regulations that
 regulate the inclusion or use of controlled substances. Toshiba assumes no liability for damage or losses occurring
 as a result of noncompliance with applicable laws and regulations.
- For a discussion of how the reliability of microcontrollers can be predicted, please refer to Section 1.3 of the chapter entitled Quality and Reliability Assurance/Handling Precautions.

5. Publication date of the datasheet

The publication date of this datasheet is printed at the lower right corner of this notification.

(Annex)

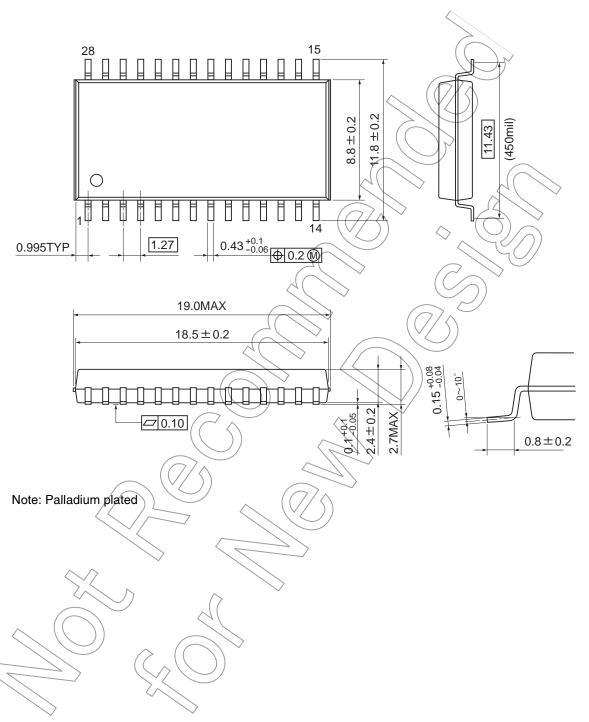
Package Dimensions



III 2008-03-06

SOP28-P-450-1.27B

Unit: mm



IV 2008-03-06

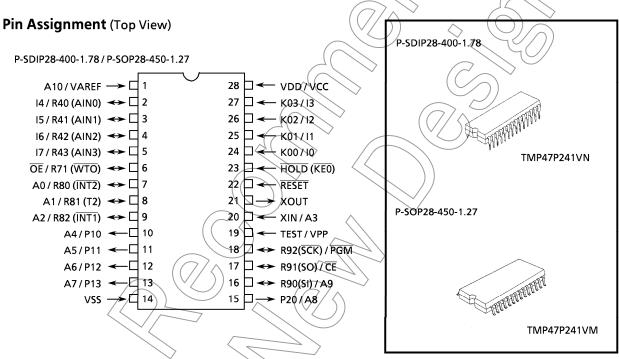
CMOS 4-Bit Microcontroller

TMP47P241VN **TMP47P241VM**

The TMP47P241V is the system evaluation LSI of TMP47C241 with a 16 Kbit one-time PROM. The TMP47P241V programs / verifies using an adapter socket to connect with PROM programmer, as it is in TMM2764AD.

In addition, the TMP47P241V and the TMP47C241 are pin compatible. The TMP47P241V operates as the same as the TMP47C241 by programming to the internal PROM.

Part No.	ROM	RAM	Package	Adaptor Socket
TMP47P241VN	OTP	1204 6:4	P-SDIP28-400-1.78	BM1156
TMP47P241VM	2048 × 8-bit	128 × 4-bit	P-SOP28-450-1.27	BM1157



For a discussion of how the reliability of microcontrollers can be predicted, please refer to Section 1.3 of the chapter entitled Quality and Reliability Assurance / Handling Precautions.

TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor

TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.. The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's

The products described in this document are subject to the foreign exchange and foreign trade laws.

The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any intellectual property or other rights of TOSHIBA CORPORATION or others.

The information contained herein is subject to change without notice.

6-41-31 2000-10-19

Pin Function

The TMP47P241V has MCU mode and PROM mode.

(1) MCU mode

The TMP47C241 and the TMP47P241V are pin compatible (TEST pin for out-going test. Be fixed to low level).

(2) PROM mode

Pin Name	Input / Output	Functions	Pin Name (MCU mode)
A10			VAREF
А9		4(>	R90
A8			P20
A7 to A4	INPUT	Address inputs	P13 to P10
А3			XIN
A2 to A0			R82 to R80
17 to 14	1/0	Data outputs (Inputs)	R43 to R40
13 to 10	1/0	Data outputs (illiputs)	K03 to K00
PGM		Program control input	R92
CE	Input	Chip Enable input	R91
ŌĒ		Output Enable input	R71
VPP		+ 12.5 V λ 5 V (Program supply voltage)	TEST
vcc	Power supply	+5V	VDD
VSS		99	VSS
RESET	Input	DROM made atting his Defined to level and	
HOLD	Input	PROM mode setting pin. Be fixed to low level.	
хоит	Input	Input the clock from the external oscillator.	

Operational Description

The following is an explanation of hardware configuration and operation in relation to the TMP47P241V. The TMP47P241V is the same as the TMP47C241 except that an OTP is used instead of a built-in mask ROM.

1. Operation mode

The TMP47P241V has an MCU mode and a PROM mode.

1.1 MCU mode

The MCU mode is set by fixing the TEST/VPP pin at the "L" level. Operation in the MCU mode is the same as for the TMP47C241, except that the TEST/VPP pin does not have built in pull-down resistor and cannot be used open. In the TMP47P241V, RC oscillation is impossible.

1.1.1 Program Memory

The program storage area is the same as for the TMP47C241.

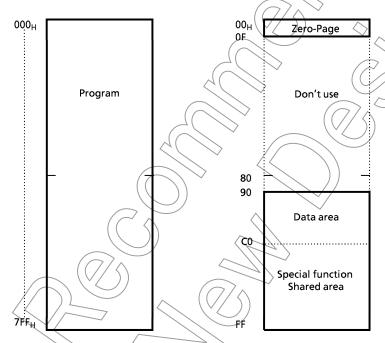


Figure 1-1. Program area (RQM)

Figure 1-2. RAM addressing

1.1.2 Data Memory

The TMP47P241V has 128 x 4-bit of data memory (RAM).

When the TMP47C940A is used as evaluator of the TMP47C241V, programming should be performed assuming that the RAM is assigned to addresses 00 to 7F_H and 90 to FF_H as show in Figure 1-2 by considering the application software evaluation. When the BM47214A (emulator) is used as the TMP47C241 evaluator, it is same.

1.1.3 Input / Output Circuitry

(1) Control pins

This is the same as for the TMP47C241 except that there is no built-in pull-down resistance for the TEST pin. In the TMP47P241V, RC oscillation is impossible. Connecting the resonator is required when using as evaluator of I/O code SG.

6-41-33 2000-10-19

(2) I/O Ports

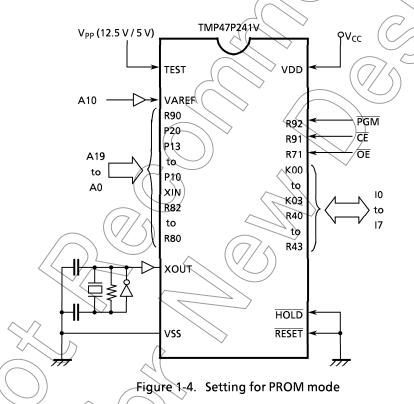
The input/output circuit of the TMP47P241V is the same as I/O code SA of the TMP47C241. External resistance, for example, is required when using as evaluator of other I/O codes (SB, SC).



Figure 1-3. I/O code and external circuitry

1.2 PROM mode

The PROM mode is set by setting the RESET, HOLD pins to the "L" level. In PROM mode, programs can be written or verified using a general-purpose PROM writer with an adapter socket being attached. (A high-speed program mode is used is used set the ROM type the same as for the TMM2764AD.)



1.2.1 Program Writing

When writing a program, set a ROM type to "2764A" (programming voltage: 12.5 V) . Since the TMP47P241V has a 2048 \times 8-bit internal PROM (000 to 7FF_H), set a stop address of a PROM writer to "7FF_H". For a general-purpose PROM writer, use the writer which does not have or can release an electric signature mode.

1.2.2 High Speed Programming Mode

The program time can be greatly decreased by using this high speed programming mode. The device is set up in the high speed programming mode when the programming voltage (+ 12.5 V) is applied to the V_{PP} terminal with $V_{CC} = 6 \text{ V}$ and $\overline{PGM} = V_{IH}$.

The programming is achieved by applying a single low level 1ms pulse the \overline{PGM} input after addresses and data are stable. Then the programmed data is verified by using Program Verify Mode.

If the programmed data is not correct, another program pulse of 1ms is applied and then programmed data is verified. This should be repeated until the program operates correctly (max. 25 times).

After correctly programming the selected address, one additional program pulse with pulse width 3 times that needed for programming is applied.

When programming has been completed, the data in all addresses should be verified with $V_{CC} = V_{PP} = 5 \text{ V}$.

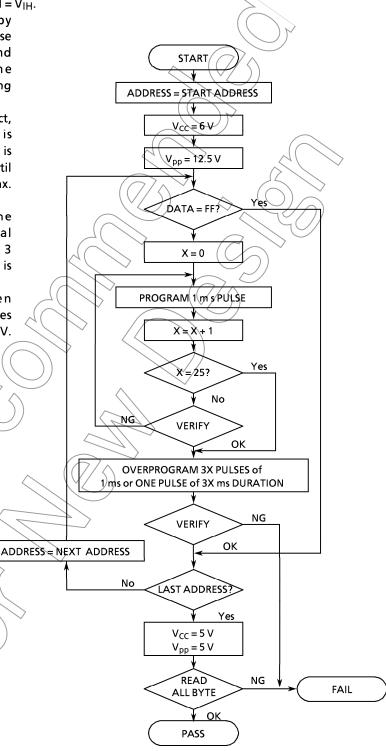


Figure 1-5. Flowchart

Electrical Characteristics

Absolute Maximum Ratings

 $(V_{SS} = 0 V)$

Parameter	Symbol	Pins	Ratings	Unit
Supply Voltage	V_{DD}		=0.3 to 7	٧
Program Voltage	V_{PP}	HOLD/VPP pin		٧
Input Voltage	V_{IN}		-0.3 to $V_{DD} + 0.3$	V
	V _{OUT1}	Except sink open drain pin	- 0.3 to V _{DD} + 0.3	
Output Voltage	V_{OUT2}	Ports P1, P2, R7 to R9	– 0.3 to 10	V
	V _{OUT3}	Port R4 (Analog inputs)	- 0.3 to V _{DD} + 0.3	
	I _{OUT1}	Ports P1, P2	30	
Output Current (Per 1 pin)	I _{OUT2}	Port R9	(15)	mA
	I _{OUT3}	Ports R4, R7, R8	3.2	
Output Current (Total)	Σ I _{OUT1}	Ports P1, P2, R9	120	mA
Power Dissipation [Topr = 70°]	PD		300	mW
Soldering Temperature (time)	Tsld		260 (10.s)	°C
Storage Temperature	Tstg		- 55 to 125	°C
Operating Temperature	Topr	4()	– 30 to 70	°C

Note: The absolute maximum ratings are rated values which must not be exceeded during operation, even for an instant. Any one of the ratings must not be exceeded. If any absolute maximum rating is exceeded, a device may break down or its performance may be degraded, causing it to catch fire or explode resulting in injury to the user. Thus, when designing products which include this device, ensure that no absolute maximum rating value will ever be exceeded.

Recommended Operating Conditions $(V_{SS}=0 \text{ V, Topr} = -30 \text{ to } 70^{\circ}\text{C})$

Parameter	Symbol	Pins	Conditions	Min	Max	Unit	
		7/^	$f_c = 6.0 \text{MHz}$	4.5			
Supply Voltage	V _{DD}	$(\langle \ \rangle)$	fc=4.2 MHz	2.7	6.0	V	
			In the HOLD mode	2.0			
	V _{IH1}	Except Hysteresis Input	In the normal	$V_{DD} \times 0.7$			
Input High Voltage	V _{IH2}	V _{IH2} Hysteresis Input		operating area	$V_{DD} \times 0.75$	V _{DD}	V
	VH3>		In the HOLD mode	$V_{DD} \times 0.9$			
^ ^	V _{IL1}	Except Hysteresis Input	In the normal		$V_{DD} \times 0.3$		
Input Low Voltage	V_{IL2}	Hysteresis Input	operating area	0	$V_{DD} \times 0.25$	V	
	$)$ V_{IL3}	\wedge	In the HOLD mode		$V_{DD} \times 0.1$		
Clock Frequency	fc	M	V _{DD} = 4.5 to 6.0 V	0.4	6.0	MHz	
	ΙC		$V_{DD} = 2.7 \text{ to } 6.0 \text{ V}$	0.4	4.2	IVITZ	

The recommended operating conditions for a device are operating conditions under which it can be guaranteed that the device will operate as specified. If the device is used under operating conditions other than the recommended operating conditions (supply voltage, operating temperature range, specified AC/DC values etc.), malfunction may occur. Thus, when designing products which include this device, ensure that the recommended operating conditions for the device are always adhered to.

DC Characteristics

 $(V_{SS} = 0 \text{ V}, \text{ Topr} = -30 \text{ to } 70^{\circ}\text{C})$

Parameter	Symbol	Pins	Conditions	Min	Тур.	Max	Unit
Hysteresis Voltage	V _{HS}	Hysteresis Input		(0.7	_	V
	I _{IN1}	Port K0, TEST, RESET, HOLD	V _{DD} = 5.5 V,	$\langle \rangle$			
Input Current	I _{IN2}	Ports R (open drain)	V _{IN} = 5.5 V / 0 V		1	± 2	μΑ
	R _{IN1}	Port K0 with pull-up/pull-down		30	70	150	- 0
Input Registance	R _{IN2}	RESET		100	220	450	kΩ
Output Leakage Current	I _{LO}	Ports R, P (open drain)	$V_{DD} = 5.5 \text{ V}, V_{QUT} = 5.5 \text{ V}$		<u>, </u>	2	μΑ
Output Low Voltage	V _{OL2}	Except XOUT, ports P	V _{DD} = 4.5 V, I _{QL} = 1.6 mA	4		0.4	V
	I _{OL1}	Ports P1, P2) _/ /	20) –	
Low Output Current	I _{OL2}	Port R9	$V_{DD} = 4.5 \text{ V}, V_{OL} = 1.0 \text{ V}$) (> 7	_	mA
Supply Current		4	$V_{DD} = 5.5 \text{ V}, \text{ fc} = 4 \text{ MHz}$	$\langle \gamma \rangle$	2	4	
(in the Normal mode)	I_{DD}		$V_{DD} = 3.0 \text{ V, fc} = 4 \text{ MHz}$	\hookrightarrow	1	2	mA
,			$V_{DD} = 3.0 \text{ V}, \text{ fc} = 400 \text{ kHz}$		0.5	1	
Supply Current (in the HOLD mode)	I _{DDH}		V _{DD} = 5,5 V		0.5	10	μΑ

Note 1: Typ. values show those at $T_{opr} = 25$ °C, $V_{DD} = 5$ V.

Note 2: Input Current I_{IN1}; The current through resistor is not included, when the input resistor (pull-up / pull-down) is contained.

Note 3: Supply Current I_{DD} , I_{DDH} ; $V_{IN} = 5.3 V/0.2 V$

The KO port is open when the input resistor is contained. The voltage applied to the R port is within the valid range.

AD Conversion Characteristics

 $(\nabla \rho pr \neq -30 \text{ to } 70^{\circ}\text{C})$

Parameter	Symbol	Conditions	Min	Тур.	Max	Unit
Analog Reference Voltage	V _{AREF}		V _{DD} – 1.5	_	V _{DD}	V
Analog Reference Voltage Range	ΔVAREF	V _{AREF} - V _{SS}	2.7	_	_	V
Analog Input Voltage	VAIN		V _{SS}	_	V _{AREF}	V
Analog Supply current	I _{REF}	\triangleright	_	0.5	1.0	mA
Nonlinearity Error			_	_	± 1	
Zero Point Error		$V_{DD} = 5.0 \text{ V}, V_{SS} = 0.0 \text{ V}$	_	_	± 1	LSB
Full Scale Error		V _{AREF} = 5.000 V	_	_	± 1	LJD
Total Error		V _{ASS} = 0.000 V	_	_	± 2	

1.5 V

AC Characteristics

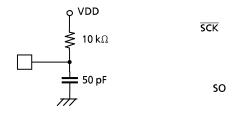
 $(V_{SS} = 0 \text{ V}, \text{ Topr} = -30 \text{ to } 70^{\circ}\text{C})$

Parameter	Symbol	Conditions	Min	Тур.	Max	Unit
Instruction Cycle Time		V _{DD} = 4.5 to 6.0 V	1.3	$\bigcirc \nearrow$		
	t _{cy}	V _{DD} = 2.7 to 6.0 V	1,9		20	μS
High level Clock pulse Width	t _{WCH}	External clock mode)		
Low level Clock pulse Width	t _{WCL}	External clock mode	80		ı	ns
AD Sampling Time	t _{AIN}	fc = 4 MHz		4)	μS
Shift Data Hold Time	t _{SDH}		$0.5 t_{cy} - 0.3$	(_{>} μs

Note: Shift Data Hold Time

External circuit for SCK pin and SO pin





Recommended Oscillating Conditions

 $(V_{SS} = 0 \text{ V}, V_{DD} = 4.5 \text{ to } 6.0 \text{ V}, \text{ Topr} = -40 \text{ to } 70^{\circ}\text{C})$

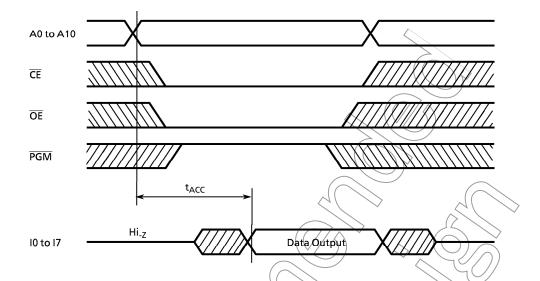
Recommended oscillating conditions of the TMP47P241V are equal to the TMP47C241's but RC oscillation is impossible.

DC/AC Characteristics

 $(\forall_{SS} = 0 \text{ V})$

(1) Read Operation

Parameter	Symbol	Condition	Min	Тур.	Max	Unit
Output Level High Voltage	V _{IH4}	\nearrow	$V_{CC} \times 0.7$	-	V _{CC}	٧
Output Level Low Voltage	V _{IL4}		0	-	V _{CC} × 0.3	٧
Supply Voltage Programming Voltage	VCC V _{PP}		4.75	-	6.0	V
Address Access Time	t _{ACC}	V _{CC} = 5.0 ± 0.25 V	0	-	350	ns



(2) High Speed Programming Operation

Parameter	Symbol	Condition	Min	Тур.	Max	Unit
Input High Voltage	V _{IH4}		V _{CC} ×0.7	<u> </u>	V _{CC}	V
Input Low Voltage	V _{IL4}		0	-	V _{CC} × 0.3	٧
Supply Voltage	V _{CC}		4.75	-	6.0	٧
V _{PP} Power Supply Voltage	V _{PP}		12.00	12.50	13.00	٧
Programming Pulse Width	tpw	V _{CO} =6.0 ± 0.25 V	0.95	1.0	1.05	ms

